Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/058,735	LEE, EUN-BAE
Examiner	Art Unit
John R. Cottingham	2116

	SEAR	CHED	
Class	Subclass	Date	Examiner
713	310	4/26/2005	JRC
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Trujillo - cl. 713	4/26/2005	JRC	
text search attached	4/26/2005	JRC	
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